

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1776		SERIAL NO. 09/943,180	
<div style="display: flex; align-items: center;"> <div> <p>LIST OF ART CITED BY APPLICANT</p> <p>(Use several sheets if necessary)</p> </div> </div>				APPLICANT: John T. Moore et al.			
				FILING DATE August 29, 2001		GROUP 2825	
U.S. PATENT DOCUMENTS							
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
V4	AA	6,436,771 B1	08/20/02	Jang et al.			
	AB						
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FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
	AJ						
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AM						
	AN						
	AO						
EXAMINER V. Y. Lee		DATE CONSIDERED 11/16/04					
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							

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6-24-03

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U.S. PATENT DOCUMENTS							
Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
RML	AA	8,399,448 B1	08/04/02	Mukhopadhyay et al.	—	—	
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		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
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	AL						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
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DATE CONSIDERED BY EXAMINER		DATE CONSIDERED BY EXAMINER					
10/6/2003		Rexa R. Pacheco					
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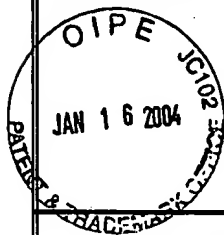
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1776	SERIAL NO. 09/943,180		
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small>				APPLICANT: John T. Moore et al.			
				FILING DATE August 29, 2001	GROUP 2825		
U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
Vy	AA	6,350,707 B1	02-2002	Liu et al.			
	AB						
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FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER N. Guevara		DATE CONSIDERED 11/16/04					
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August 29, 2001GROUP
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U.S. PATENT DOCUMENTS

*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
VY	AA	6,110,780	08-2000	Yu et al.			
VY	AB	6,265,327	07-2001	Kobayashi et al.			
	AC						
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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

V. Yue-Mon

DATE CONSIDERED

11/16/04

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